

DATA SHEET

74LV20

Dual 4-input NAND gate

Product data
Supersedes data of 1998 Apr 20

2003 Mar 10

Dual 4-input NAND gate

74LV20

FEATURES

- Optimized for Low Voltage applications: 1.0 V to 3.6 V
- Accepts TTL input levels between $V_{CC} = 2.7$ V and $V_{CC} = 3.6$ V
- Typical V_{OLP} (output ground bounce) < 0.8 V @ $V_{CC} = 3.3$ V, $T_{amb} = 25$ °C
- Typical V_{OHV} (output V_{OH} undershoot) > 2 V @ $V_{CC} = 3.3$ V, $T_{amb} = 25$ °C
- Output capability: standard
- I_{CC} category: SSI

DESCRIPTION

The 74LV20 is a low-voltage Si-gate CMOS device and is pin and function compatible with 74HC/HCT20.

The 74LV20 provides the 4-input NAND function.

QUICK REFERENCE DATA

GND = 0 V; $T_{amb} = 25$ °C; $t_r = t_f \leq 2.5$ ns

SYMBOL	PARAMETER	CONDITIONS	TYPICAL	UNIT
t_{PHL}/t_{PLH}	Propagation delay nA, nB, nC, nD to nY	$C_L = 15$ pF $V_{CC} = 3.3$ V	8	ns
C_I	Input capacitance		3.5	pF
C_{PD}	Power dissipation capacitance per gate	Notes 1 and 2	22	pF

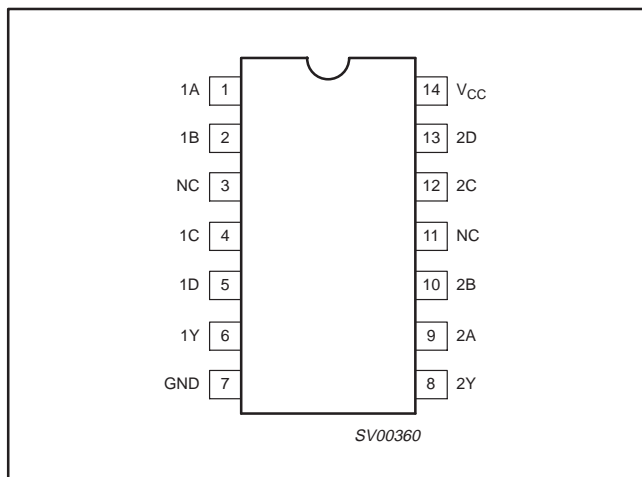
NOTES:

- C_{PD} is used to determine the dynamic power dissipation (P_D in μ W)
 $P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \sum (C_L \times V_{CC}^2 \times f_o)$ where:
 N = number of outputs switching;
 f_i = input frequency in MHz; C_L = output load capacitance in pF;
 f_o = output frequency in MHz; V_{CC} = supply voltage in V;
 $\sum (C_L \times V_{CC}^2 \times f_o)$ = sum of the outputs.
- The condition is $V_I = \text{GND to } V_{CC}$

ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	ORDER CODE	PKG. DWG. #
14-Pin Plastic SO	-40 °C to +125 °C	74LV20D	SOT108-1

PIN CONFIGURATION



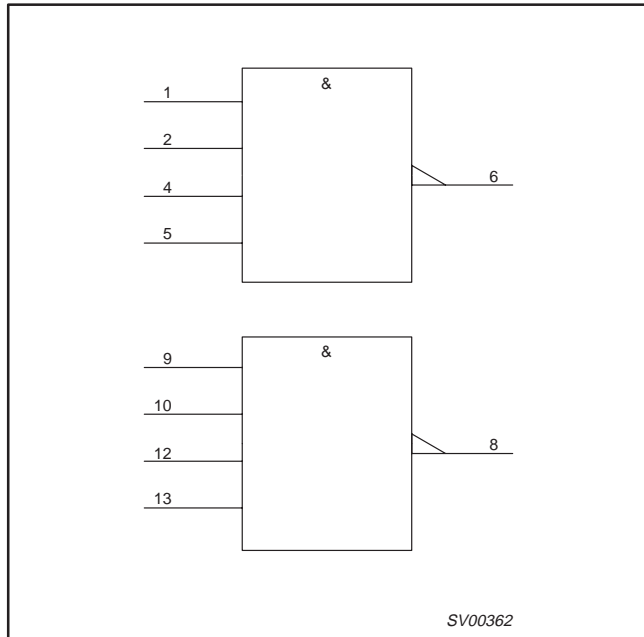
PIN DESCRIPTION

PIN NUMBER	SYMBOL	FUNCTION
1, 9	1A to 2A	Data inputs
2, 10	1B to 2B	Data inputs
3, 11	NC	No connection
4, 12	1C to 2C	Data inputs
5, 13	1D to 2D	Data inputs
6, 8	1Y to 2Y	Data outputs
7	GND	Ground (0 V)
14	V_{CC}	Positive supply voltage

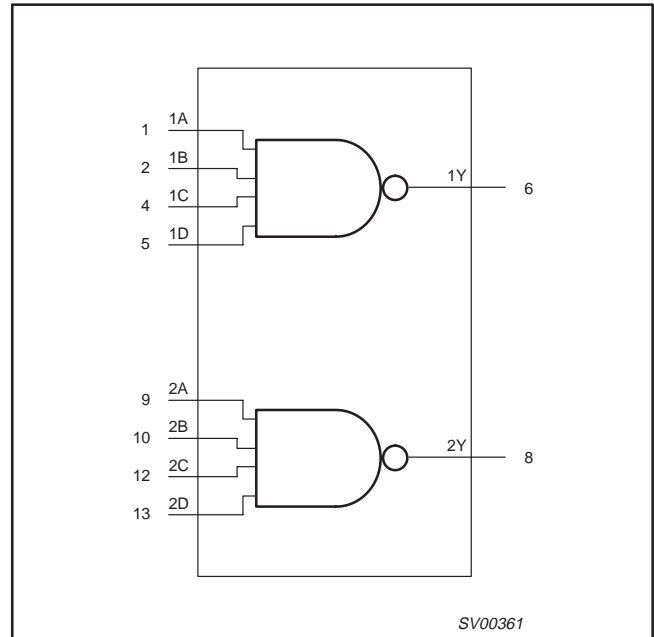
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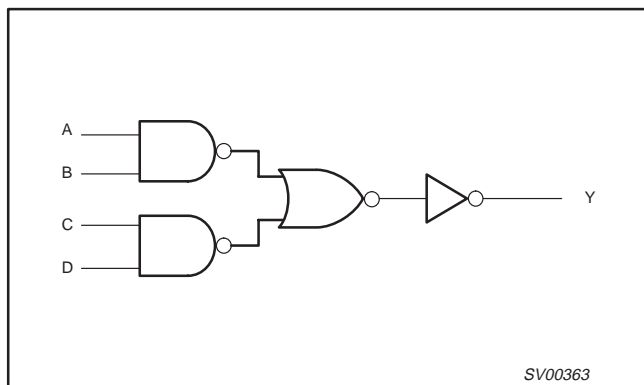
LOGIC SYMBOL (IEEE/IEC)



LOGIC SYMBOL



LOGIC DIAGRAM



FUNCTION TABLE

INPUTS				OUTPUTS
nA	nB	nC	nD	nY
L	X	X	X	H
X	L	X	X	H
X	X	L	X	H
X	X	X	L	H
H	H	H	H	L

NOTES:
 H = HIGH voltage level
 L = LOW voltage level
 X = Don't care

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP.	MAX	UNIT
V_{CC}	DC supply voltage	See Note 1	1.0	3.3	3.6	V
V_I	Input voltage		0	–	V_{CC}	V
V_O	Output voltage		0	–	V_{CC}	V
T_{amb}	Operating ambient temperature range in free air	See DC and AC characteristics	–40 –40		+85 +125	°C
t_r, t_f	Input rise and fall times	$V_{CC} = 1.0\text{ V to }2.0\text{ V}$	–	–	500	ns/V
		$V_{CC} = 2.0\text{ V to }2.7\text{ V}$	–	–	200	ns/V
		$V_{CC} = 2.7\text{ V to }3.6\text{ V}$	–	–	100	ns/V

NOTE:

1 The LV is guaranteed to function down to $V_{CC} = 1.0\text{ V}$ (input levels GND or V_{CC}); DC characteristics are guaranteed from $V_{CC} = 1.2\text{ V}$ to $V_{CC} = 3.6\text{ V}$.

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ABSOLUTE MAXIMUM RATINGS^{1, 2}

In accordance with the Absolute Maximum Rating System (IEC 134). Voltages are referenced to GND (ground = 0 V).

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V_{CC}	DC supply voltage		-0.5 to +4.6	V
$\pm I_{IK}$	DC input diode current	$V_I < -0.5 \text{ V}$ or $V_I > V_{CC} + 0.5 \text{ V}$	20	mA
$\pm I_{OK}$	DC output diode current	$V_O < -0.5 \text{ V}$ or $V_O > V_{CC} + 0.5 \text{ V}$	50	mA
$\pm I_O$	DC output source or sink current (standard outputs)	$-0.5 \text{ V} < V_O < V_{CC} + 0.5 \text{ V}$	25	mA
$\pm I_{GND}$, $\pm I_{CC}$	DC V_{CC} or GND current for types with standard outputs		50	mA
T_{stg}	Storage temperature range		-65 to +150	°C
P_{TOT}	Power dissipation per package -plastic mini-pack (SO)	for temperature range: -40 °C to +125 °C above +70 °C derate linearly with 8 mW/K	500	mW

NOTES:

- Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

DC CHARACTERISTICS

Over recommended operating conditions voltages are referenced to GND (ground = 0 V).

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS					UNIT
			-40 °C to +85 °C			-40 °C to +125 °C		
			MIN	TYP ¹	MAX	MIN	MAX	
V_{IH}	HIGH level Input voltage	$V_{CC} = 1.2 \text{ V}$	0.9			0.9		V
		$V_{CC} = 2.0 \text{ V}$	1.4			1.4		
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2.0			2.0		
V_{IL}	LOW level Input voltage	$V_{CC} = 1.2 \text{ V}$			0.3		0.3	V
		$V_{CC} = 2.0 \text{ V}$			0.6		0.6	
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$			0.8		0.8	
V_{OH}	HIGH level output voltage; all outputs	$V_{CC} = 1.2 \text{ V}; V_I = V_{IH}$ or $V_{IL}; -I_O = 100 \mu\text{A}$		1.2				V
		$V_{CC} = 2.0 \text{ V}; V_I = V_{IH}$ or $V_{IL}; -I_O = 100 \mu\text{A}$	1.8	2.0		1.8		
		$V_{CC} = 2.7 \text{ V}; V_I = V_{IH}$ or $V_{IL}; -I_O = 100 \mu\text{A}$	2.5	2.7		2.5		
		$V_{CC} = 3.0 \text{ V}; V_I = V_{IH}$ or $V_{IL}; -I_O = 100 \mu\text{A}$	2.8	3.0		2.8		
V_{OH}	HIGH level output voltage; STANDARD outputs	$V_{CC} = 3.0 \text{ V}; V_I = V_{IH}$ or $V_{IL}; -I_O = 6 \text{ mA}$	2.40	2.82		2.20		V
V_{OL}	LOW level output voltage; all outputs	$V_{CC} = 1.2 \text{ V}; V_I = V_{IH}$ or $V_{IL}; I_O = 100 \mu\text{A}$		0				V
		$V_{CC} = 2.0 \text{ V}; V_I = V_{IH}$ or $V_{IL}; I_O = 100 \mu\text{A}$		0	0.2		0.2	
		$V_{CC} = 2.7 \text{ V}; V_I = V_{IH}$ or $V_{IL}; I_O = 100 \mu\text{A}$		0	0.2		0.2	
		$V_{CC} = 3.0 \text{ V}; V_I = V_{IH}$ or $V_{IL}; I_O = 100 \mu\text{A}$		0	0.2		0.2	
V_{OL}	LOW level output voltage; STANDARD outputs	$V_{CC} = 3.0 \text{ V}; V_I = V_{IH}$ or $V_{IL}; I_O = 6 \text{ mA}$		0.25	0.40		0.50	V
I_I	Input leakage current	$V_{CC} = 3.6 \text{ V}; V_I = V_{CC}$ or GND			1.0		1.0	μA
I_{CC}	Quiescent supply current; SSI	$V_{CC} = 3.6 \text{ V}; V_I = V_{CC}$ or GND; $I_O = 0$			20.0		40	μA
ΔI_{CC}	Additional quiescent supply current per input	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}; V_I = V_{CC} - 0.6 \text{ V}$			500		850	μA

NOTE:

- All typical values are measured at $T_{amb} = 25 \text{ °C}$.

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AC CHARACTERISTICS

GND = 0 V; $t_r = t_f \leq 2.5$ ns; $C_L = 50$ pF; $R_L = 1$ k Ω

SYMBOL	PARAMETER	WAVEFORM	CONDITION	LIMITS -40 to +85 °C			LIMITS -40 to +125 °C		UNIT
			V _{CC} (V)	MIN	TYP ¹	MAX	MIN	MAX	
t _{PHL} /t _{PLH}	Propagation delay nA, nB, nC, nD to nY	Figures 1, 2	1.2	-	50	-	-	-	ns
			2.0	-	17	32	-	39	
			2.7	-	13	24	-	29	
			3.0 to 3.6	-	10 ²	19	-	23	

NOTE:

- 1 Unless otherwise stated, all typical values are at T_{amb} = 25 °C.
- 2 Typical value measured at V_{CC} = 3.3 V.

AC WAVEFORMS

V_M = 1.5 V at V_{CC} ≥ 2.7 V ≤ 3.6 V

V_M = 0.5 V * V_{CC} at V_{CC} < 2.7 V

V_{OL} and V_{OH} are the typical output voltage drop that occur with the output load.

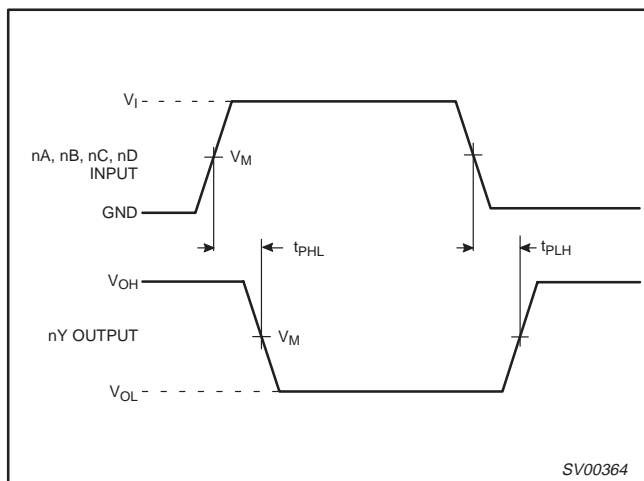


Figure 1. Input (nA, nB, nC, nD) to output (nY) propagation delays.

TEST CIRCUIT

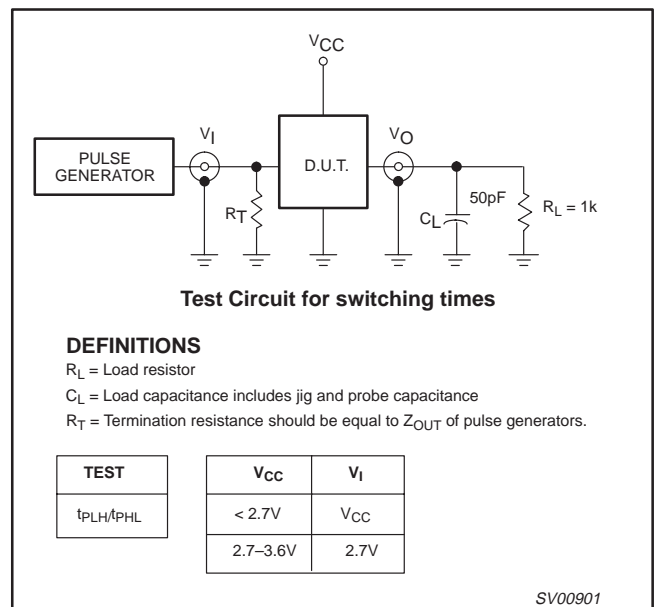


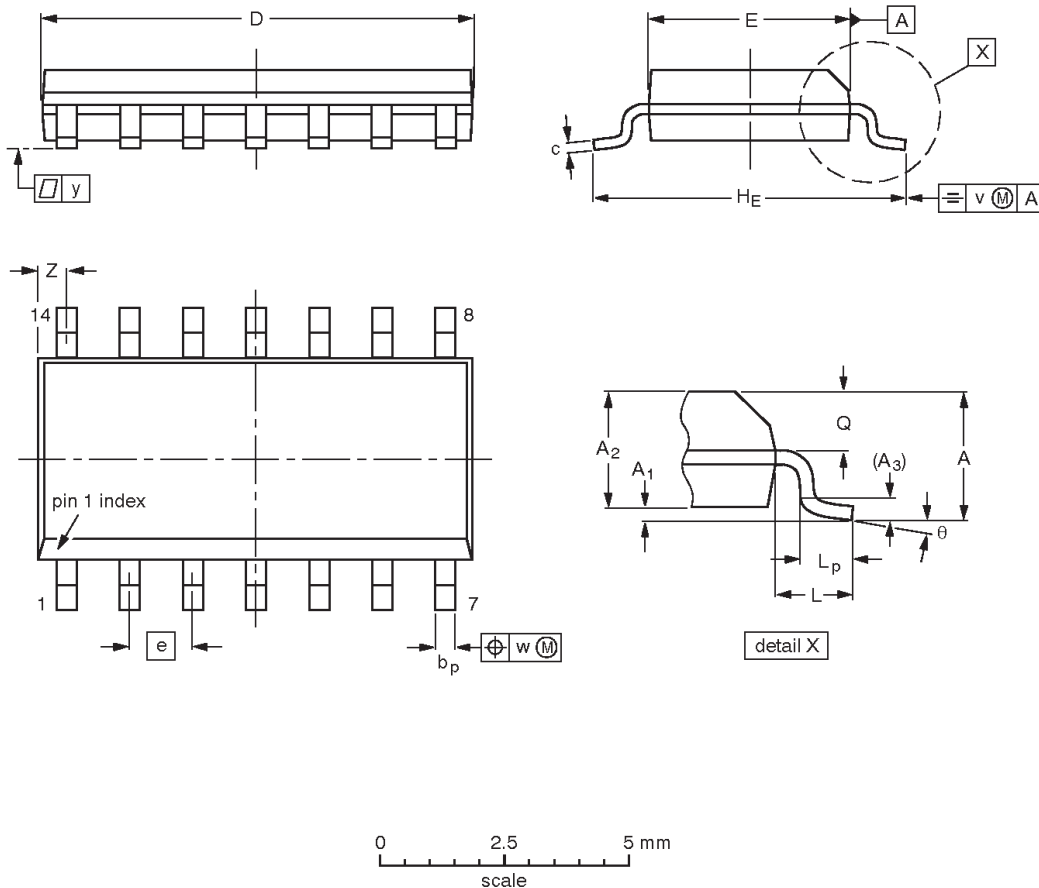
Figure 2. Load circuitry for switching times.

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SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁	A ₂	A ₃	b _p	c	D ⁽¹⁾	E ⁽¹⁾	e	H _E	L	L _p	Q	v	w	y	Z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	8.75 8.55	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8° 0°
inches	0.069	0.010 0.004	0.057 0.049	0.01	0.019 0.014	0.0100 0.0075	0.35 0.34	0.16 0.15	0.050	0.244 0.228	0.041	0.039 0.016	0.028 0.024	0.01	0.01	0.004	0.028 0.012	

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT108-1	076E06	MS-012				97-05-22 99-12-27

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REVISION HISTORY

Rev	Date	Description
_4	20030310	Product data (9397 750 11224). ECN 853-1962 29493 of 07 February 2003. Supersedes Product specification of 1998 Apr 20 (9397 750 04411). Modifications: <ul style="list-style-type: none">• Delete DIL, SSOP and TSSOP package ordering and package outlines (discontinued options).• Quick Reference Data: Correct power dissipation formula in Note 1.
_3	19980420	Product specification (9397 750 04411). ECN 853-1962 19256 of 20 April 1998. Supersedes data of 1997 Mar 28.

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Data sheet status

Level	Data sheet status ^[1]	Product status ^{[2] [3]}	Definitions
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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